Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/647,102	ABERLE ET AL.
Examiner	Art Unit
Yoon-Young Kim	1723

	SEARCHED		
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Inventor Search	1/4/2006	YK	
See EAST History	1/6/2006	YK	